

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/660,106	MIURA, TAKAYOSHI	
		Examiner	Art Unit	Page 1 of 1
		Stephen Avila	3617	

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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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